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L17

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*DB=USPT; PLUR=YES; OP=ADJ*

<u>L17</u>	I9 and I6	0	<u>L17</u>
<u>L16</u>	I9 and I11	0	<u>L16</u>
<u>L15</u>	I6 and I13	3	<u>L15</u>
<u>L14</u>	I11 and L13	1	<u>L14</u>
<u>L13</u>	(trigger\$ and table\$).ab.	196	<u>L13</u>
<u>L12</u>	I7 and L11	183	<u>L12</u>
<u>L11</u>	trigger\$ near3 inoperat\$	341	<u>L11</u>
<u>L10</u>	I8 and L9	0	<u>L10</u>
<u>L9</u>	((707/\$)!.CCLS.)	11472	<u>L9</u>
<u>L8</u>	I6 and L7	228	<u>L8</u>
<u>L7</u>	trigger\$.ab.	21166	<u>L7</u>
<u>L6</u>	trigger\$ near5 inoperat\$	472	<u>L6</u>

*DB=USPT,PGPB,JPAB,EPAB,DWPI,TDBD; PLUR=YES; OP=ADJ*

<u>L5</u>	trigger\$ near5 inoperat\$	585	<u>L5</u>
<u>L4</u>	trigger\$ near5 (inoperat\$ or run\$ or work\$ or stop\$)	15903	<u>L4</u>

*DB=PGPB; PLUR=YES; OP=ADJ*

<u>L3</u>	L2 and inoperative	1	<u>L3</u>
<u>L2</u>	(object and trigger).ti.	1	<u>L2</u>
<u>L1</u>	(object and trigger).ab.	86	<u>L1</u>

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L15: Entry 1 of 3

File: USPT

Sep 4, 2001

US-PAT-NO: 6286102

DOCUMENT-IDENTIFIER: US 6286102 B1

TITLE: Selective wireless disablement for computers passing through a security checkpoint

DATE-ISSUED: September 4, 2001

## INVENTOR-INFORMATION:

NAME	CITY	STATE	ZIP CODE	COUNTRY
Cromer; Daryl	Cary	NC		
Dayan; Richard	Wake Forest	NC		
Locker; Howard	Cary	NC		
Steinmetz; Mike	Cary	NC		
Ward; Jim	Raleigh	NC		

US-CL-CURRENT: 713/200

<a href="#">Full</a>	<a href="#">Title</a>	<a href="#">Citation</a>	<a href="#">Front</a>	<a href="#">Review</a>	<a href="#">Classification</a>	<a href="#">Date</a>	<a href="#">Reference</a>	<a href="#">Sequences</a>	<a href="#">Attachments</a>	<a href="#">Claims</a>	<a href="#">RMC</a>	<a href="#">Draw Desc</a>	<a href="#">Image</a>
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☐ 2. Document ID: US 5970227 A

L15: Entry 2 of 3

File: USPT

Oct 19, 1999

US-PAT-NO: 5970227

DOCUMENT-IDENTIFIER: US 5970227 A

TITLE: Wireless proximity detector security feature

DATE-ISSUED: October 19, 1999

## INVENTOR-INFORMATION:

NAME	CITY	STATE	ZIP CODE	COUNTRY
Dayan; Richard A.	Wake Forest	NC		
McGovern; Joseph P.	Apex	NC		
Newman; Palmer E.	Apex	NC		

US-CL-CURRENT: 713/200; 340/5.3, 340/5.61, 713/183

Full	Title	Citation	Front	Review	Classification	Date	Reference	Sequences	Attachments
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KWIC	Draw Desc	Image
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☐ 3. Document ID: US 5496992 A

L15: Entry 3 of 3

File: USPT

Mar 5, 1996

US-PAT-NO: 5496992

DOCUMENT-IDENTIFIER: US 5496992 A

TITLE: Dual trigger multiplexed data entry terminal

DATE-ISSUED: March 5, 1996

## INVENTOR-INFORMATION:

NAME	CITY	STATE	ZIP CODE	COUNTRY
Madan; Esteban C.	Duluth	GA		
Beebe; Randolph R.	Duluth	GA		
Stanfield; Teresa H.	Lawrenceville	GA		

US-CL-CURRENT: 235/472.02; 235/462.48, 341/23, 708/144

Full	Title	Citation	Front	Review	Classification	Date	Reference	Sequences	Attachments
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KWIC	Draw Desc	Image
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**1 From trendcharts to control charts: setup tests for making the leap***Abugov, R.;*Semiconductor Manufacturing Science Symposium, 1992. ISMSS 1992.,  
IEEE/SEMI International , 15-16 June 1992

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